

<b>Notice of References Cited</b>	Application/Control No. 09/932,202		Applicant(s)/Patent Under Reexamination ELMAN ET AL.	
	Examiner Olisa Anwah		Art Unit 2645	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A US-2004/0137945	07-2004	Takagi et al.	455/558
	B US-2002/0160751	10-2002	Sun et al.	455/412
	C US-2003/0032447	02-2003	Bulthuis, Willem	455/556
	D US-5,524,137	06-1996	Rhee, David R.	379/88.01
	E US-			
	F US-			
	G US-			
	H US-			
	I US-			
	J US-			
	K US-			
	L US-			
	M US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				
	O				
	P				
	Q				
	R				
	S				
	T				

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V
	W
	X

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